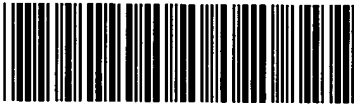


Search Notes

Application/Control No.

10/533,237

Examiner

Bao-Thuy L. Nguyen

Applicant(s)/Patent under
Reexamination

TANAKA ET AL.

Art Unit

1641

SEARCHED

Class	Subclass	Date	Examiner
436	514, 518, 523, 524, 532, 534	11/28/2007	BTN
436	823, 824		
435	287.1		
435	287.2		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, NPL	11/28/2007	BTN